

Search Notes**Application/Control No.**

10/801,718

Examiner

Daniel Kim

Applicant(s)/Patent under Reexamination

HIRAIWA ET AL.

Art Unit

2185

SEARCHED

Class	Subclass	Date	Examiner
711	154, 161	3/23/2007	DK
711	162, 165	3/23/2007	DK
714	6, 7	3/23/2007	DK
714	710	3/23/2007	DK
707	201, 203	3/23/2007	DK
707	204	3/23/2007	DK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST Search	3/23/2007	DK
Inventor Name Search for DP	3/23/2007	DK
IEEE Search	3/23/2007	DK
ACM Search	3/23/2007	DK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
711	162	3/23/2007	DK
US PGPub Search		3/23/2007	DK